

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

CB TEST CERTIFICATE	
Product	Intel® NUC
Name and address of the applicant	Intel Corporation 2200 Mission College Blvd. Santa Clara California 95054-1549 United States of America
Name and address of the manufacturer	Intel Corporation 2200 Mission College Blvd. Santa Clara California 95054-1549 United States of America
Name and address of the factory	See next page(s)
Note: When more than one factory,please report on page 2	✓ Additional Information on Page 2
Ratings and Principal characteristics	I/P: 19Vdc, 3.42A; 19Vdc, 4.74 A; 20Vdc, 6 A Cl. III.
Trademark /Brand (If any)	intel.
Customer's Testing Facility (CTF) Stage used	
Model/Type Ref	xNUC11ATKx; xNUC13LCKx; xNUC13LCHx
Additional information(If necessary may also be reported on Page 2)	(where x can be a combination of alphanumeric characters, none or blank, for marketing purpose only).
	Additional Information on Page 2
A sample of the product was tested and found to be in conformity with	IEC 62368-1:2018
As shown in the Test Report Ref. No. which forms part of this Certificate	REP009615 This certificate replaces previous certificate NO119476/A1, due to technical modification, adding new models and updated the address of applicant and manufacturer.
This CB Test Certificate is issued by the National Certification Body	
Philip Pedersen vei 11, NO-1366 Lysaker, Norway	Yasaman Vadoudi
Date: 08-05-2023	Signature: Yasaman Vadoudi Certification department

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